## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SUNG ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,374,271	04-2002	Shimizu et al.	715/501.1	
*	В	US-6,137,483	10-2000	Kiyono et al. 715/500.1		
*	С	US-2002/0161603	10-2002	Gonzales, Rolando L.	705/1	
*	D	US-2003/0188262	10-2003	Maxwell et al.	715/507	
*	Е	US-2004/0054659	03-2004	McIntyre, Dale F.	707/003	
*	F	US-2005/0196074	09-2005	Deere, Emily Ann	382/305	
*	G	US-2004/0268224	12-2004	Balkus et al.	715/500.1	
	Н	US-				
	_	US				
	J	US-			÷	
	К	US-	3.0			
	L	US-	1			
	М	US-				

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

* .	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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